



501.37892X00/219801044US01

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

12-7-03

Applicant:

Yoko IKEDA et al.

Serial No.:

09/452,149

Filed:

1 December 1999

For:

INSPECTING METHOD, INSPECTING SYSTEM, AND

METHOD FOR MANUFACTURING ELECTRONIC DEVICES

Art Unit:

2623

Examiner:

Virginia M. KIBLER

Conf. No.:

9942

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Technology Center 2600

## **RESPONSE**

MS - Non Fee Amendment Commissioner for Patents POB 1450 Alexandria, Virginia 22313-1450

26 November 2003

Sir:

In response to the final Office Action mailed 27 August 2003 in connection with the above-identified application, Applicant respectfully submits the following amendments and remarks.

## PENDING CLAIMS

Claims 1-11 were pending in the application at the time of the Office Action, under consideration and subject to examination in the Office Action. Since no claims have been amended, canceled or added, Claims 1-11 remain pending for further consideration and examination in the application.